Low-Voltage CMOS Hex Buffer with Open Drain Outputs

With 5 V - Tolerant Inputs

The 74LVC07A is a high performance hex buffer operating from a 1.2 V to 5.5 V supply. High impedance TTL compatible inputs significantly reduce current loading to input drivers. These LVC devices have open drain outputs which provide the ability to set output levels, or do active–HIGH AND or active–LOW OR functions. A $V_{\rm I}$ specification of 5.5 V allows 74LVC07A inputs to be safely driven from 5.0 V devices.

Features

- Designed for 1.2 V to 5.5 V V_{CC} Operation
- 5.0 V Tolerant Inputs/Outputs
- LVTTL Compatible
- LVCMOS Compatible
- 24 mA Output Sink Capability
- Near Zero Static Supply Current (10 μA) Substantially Reduces System Power Requirements
- Latchup Performance Exceeds 250 mA
- Wired-OR, Wired-AND
- Output Level Can Be Set Externally Without Affecting Speed of Device
- ESD Performance: Human Body Model >2000 V; Machine Model >200 V
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

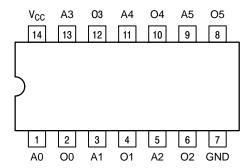


Figure 1. Pinout: 14-Lead (Top View)



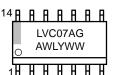
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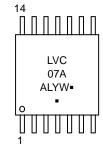


SOIC-14 D SUFFIX CASE 751A





TSSOP-14 DT SUFFIX CASE 948G



A = Assembly Location

WL, L = Wafer Lot Y = Year WW, W = Work Week G or ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

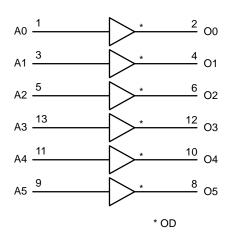


Figure 2. Logic Diagram

Table 1. PIN NAMES

Pins	Function
An	Data Inputs
On	Outputs

Table 2. TRUTH TABLE

An	On
L	L
H	Z

MAXIMUM RATINGS

Symbol	Parameter	Value	Condition	Unit
V _{CC}	DC Supply Voltage	-0.5 to +6.5		V
VI	DC Input Voltage	$-0.5 \le V_1 \le +6.5$		V
V _O	DC Output Voltage	$-0.5 \le V_O \le +6.5$	Output in 3-State	V
		$-0.5 \le V_{O} \le V_{CC} + 0.5$	Output in HIGH or LOW State (Note 1)	
I _{IK}	DC Input Diode Current	-50	V _I < GND	mA
I _{OK}	DC Output Diode Current	-50	V _O < GND	mA
		+50	V _O > V _{CC}	mA
I _O	DC Output Source/Sink Current	±50		mA
I _{CC}	DC Supply Current Per Supply Pin	±100		mA
I _{GND}	DC Ground Current Per Ground Pin	±100		mA
T _{STG}	Storage Temperature Range	-65 to +150		°C
TL	Lead Temperature, 1 mm from Case for 10 Seconds	T _L = 260		°C
TJ	Junction Temperature Under Bias	T _J = 135		°C
θJA	Thermal Resistance (Note 2)	SOIC = 85 TSSOP = 100		°C/W
MSL	Moisture Sensitivity		Level 1	
I _{LATCHUP}	Latch–up Performance at V _{CC} = 3.6 V and 125°C (Note 3)		±250	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. I_O absolute maximum rating must be observed.

2. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2 ounce copper trace no air flow.

- Measured with minimum
 Tested to EIA/JES078.

ORDERING INFORMATION

Device	Package	Shipping [†]
74LVC07ADR2G	SOIC-14 (Pb-Free)	2500 / Tape & Reel
74LVC07ADTR2G	TSSOP-14 (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter		Min	Тур	Max	Unit
V _{CC}	Supply Voltage	Operating Functional	1.65 1.2		5.5 5.5	V
VI	Input Voltage		0		5.5	V
Vo	Output Voltage	Active Mode 3–State	0 0		V _{CC} 5.5	V
I _{OL}	LOW Level Output Current	$V_{CC} = 4.5 \text{ V} - 5.5 \text{ V}$ $V_{CC} = 3.0 \text{ V} - 3.6 \text{ V}$ $V_{CC} = 2.7 \text{ V} - 3.0 \text{ V}$ $V_{CC} = 2.3 \text{ V} - 2.7 \text{ V}$			+32 +24 +12 +8	mA
T _A	Operating Free-Air Temperature		-40		+125	°C
Δt/ΔV	Input Transition Rise or Fall Rate	$V_{CC} = 1.65 \text{ to } 2.7 \text{ V}$ $V_{CC} = 2.7 \text{ to } 5.5 \text{ V}$	0 0		20 10	ns/V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

			_	40 to +85°	С	-4	0 to +125	°C	
Symbol	Parameter	Conditions	Min	Typ (Note 4)	Max	Min	Typ (Note 4)	Max	Unit
V _{IH}	HIGH-level input voltage	V _{CC} = 1.2 V	1.08	-	_	1.08	_	-	V
		V _{CC} = 1.65 V to 1.95 V	0.65 x V _{CC}	_	-	0.65 x V _{CC}	-	-	
		V _{CC} = 2.3 V to 2.7 V	1.7	-	-	1.7	_	-	
		V _{CC} = 2.7 V to 3.6 V	2.0	_	-	2.0	_	-	
		V _{CC} = 4.5 V to 5.5 V	0.7 x V _{CC}	_	-	0.7 x V _{CC}	-	-	
V _{IL}	LOW-level input voltage	V _{CC} = 1.2 V	-	-	0.12	-	_	0.12	V
		V _{CC} = 1.65 V to 1.95 V	-	-	0.35 x V _{CC}	_	-	0.35 x V _{CC}	
		V _{CC} = 2.3 V to 2.7 V	-	-	0.7	-	_	0.7	
		V _{CC} = 2.7 V to 3.6 V	-	-	0.8	-	_	0.8	
		V _{CC} = 4.5 V to 5.5 V	-	_	0.3 x V _{CC}	-	-	0.3 x V _{CC}	
V _{OL}	LOW-level output voltage	V _I = V _{IH} or	·V _{IL}	•		-	_	-	V
		$I_O = 100 \mu A;$ $V_{CC} = 1.65 \text{ V to } 3.6 \text{ V}$	_	_	0.2	_	-	0.3	
		$I_O = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.45	-	-	0.65	
		$I_{O} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	_	-	0.6	_	_	0.8	
		$I_O = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.4	-	-	0.6	
		$I_O = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	_	-	0.55	_	_	0.8	
		$I_O = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.55	-	-	0.8	
II	Input leakage current	V _I = 5.5 V or GND V _{CC} = 1.65 to 5.5 V	-	±0.1	±5	_	±0.1	±20	μΑ
I _{OZ}	OFF-state output current	$V_I = V_{IH}; V_O = 5.5 \text{ V or GND};$ $V_{CC} = 1.65 \text{ to } 5.5 \text{ V}$	-	±0.1	±5	_	±0.1	±20	μΑ
l _{OFF}	Power-off leakage current	V_{I} or $V_{O} = 5.5 \text{ V}$; $V_{CC} = 0 \text{ V}$	-	±0.1	±10	-	±0.1	±20	μΑ

^{4.} All typical values are measured at T_A = 25°C and V_{CC} = 3.3 V, unless stated otherwise.

DC ELECTRICAL CHARACTERISTICS

			−40 to +85°C		-40 to +125°C				
Symbol	Parameter	Conditions	Min	Typ (Note 4)	Max	Min	Typ (Note 4)	Max	Unit
Icc	Supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	0.1	10	_	0.1	40	μΑ
Δl _{CC}	Additional supply current	per input pin; $V_1 = V_{CC} - 0.6 \text{ V}$; $I_0 = 0 \text{ A}$; $V_{CC} = 2.7 \text{ V}$ to 5.5 V	1	5	500	1	5	5000	μΑ

^{4.} All typical values are measured at T_A = 25°C and V_{CC} = 3.3 V, unless stated otherwise.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

AC ELECTRICAL CHARACTERISTICS ($t_R = t_F = 2.5 \text{ ns}$)

			-	−40 to +85°C			40 to +125°	С	
Symbol	Parameter	Conditions	Min	Typ (Note 5)	Max	Min	Typ (Note 5)	Max	Unit
t _{pZL}	OFF-state to LOW propagation delay	V _{CC} = 1.2 V	-	8.0	_	-	_	_	ns
	An to On	V _{CC} = 1.65 V to 1.95 V	0.5	1.7	5.5	0.5	-	6.5	
		V _{CC} = 2.3 V to 2.7 V	0.5	1.2	2.8	0.5	_	3.5	
		V _{CC} = 2.7 V	0.5	1.8	3.3	0.5	_	4.5	
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	0.5	1.2	3.6	0.5	_	4.5	
		V _{CC} = 4.5 V to 5.5 V	0.5	1.6	2.6	0.5	_	3.5	
t _{pLZ}	LOW to OFF-state	V _{CC} = 1.2 V	-	10.0	-	-	_	_	ns
	propagation delay An to On	V _{CC} = 1.65 V to 1.95 V	0.5	3.0	5.5	0.5	_	6.5	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	0.5	1.7	2.8	0.5	_	3.5	
		V _{CC} = 2.7 V	0.5	2.1	3.3	0.5	_	4.5	
		V _{CC} = 3.0 V to 3.6 V	0.5	2.5	3.6	0.5	_	4.5	
		V _{CC} = 4.5 V to 5.5 V	0.5	1.6	2.6	_	_	3.5	

^{5.} Typical values are measured at $T_A = 25^{\circ}C$ and $V_{CC} = 3.3$ V, unless stated otherwise.

DYNAMIC SWITCHING CHARACTERISTICS

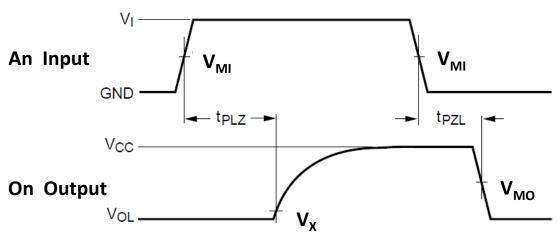
Symbol	Characteristic	Condition	Min	Тур	Max	Unit
V _{OLP}	Dynamic LOW Peak Voltage (Note 6)	$V_{CC} = 3.3 \text{ V}, C_L = 50 \text{ pF}, V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ $V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$		0.8 0.6		V
V _{OLV}	Dynamic LOW Valley Voltage (Note 6)	$V_{CC} = 3.3 \text{ V}, C_L = 50 \text{ pF}, V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ $V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$		-0.8 -0.6		V

^{6.} Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state.

CAPACITIVE CHARACTERISTICS (T_A = +25°C)

Symbol	Parameter	Condition	Typical	Unit
C _{IN}	Input Capacitance	$V_{CC} = 3.3 \text{ V}, V_I = 0 \text{ V or } V_{CC}$	5.0	pF
C _{OUT}	Output Capacitance	V_{CC} = 3.3 V, V_{I} = 0 V or V_{CC}	6.0	pF
C _{PD}	Power Dissipation Capacitance (Note 7)	Per input; V _I = GND	or V _{CC}	pF
		V _{CC} = 1.65 V to 1.95 V	6.5	1
		V _{CC} = 2.3 V to 2.7 V	6.9	1
		V _{CC} = 3.0 V to 3.6 V	7.2	

^{7.} C_{PD} is used to determine the dynamic power dissipation (P_D in μW) $P_D = C_{PD} * V_{CC}^2 x$ fi * N + L ($C_L x V_{CC}^2 x$ fo) where: fi = input frequency in MHz; fo = output frequency in MHz C_L = output load capacitance in pF V_{CC} = supply voltage in Volts N = number of outputs switching L ($C_L * V_{CC}^2$)

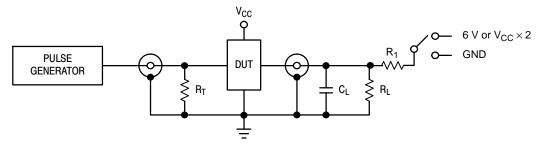


PROPAGATION DELAYS

 $t_{R}=t_{F}=2.5~\text{ns},~10\%$ to 90%; f = 1 MHz; $t_{W}=500~\text{ns}$

Table 3. AC WAVEFORMS

	V _{CC}							
Symbol	V _{CC} ≥ 4.5 to 5.5 V	V _{CC} ≥ 2.7 to 3.6 V	V _{CC} < 2.7 V					
V _{MI}	V _{CC} / 2	1.5 V	V _{CC} / 2					
V _{MO}	V _{CC} / 2	1.5 V	V _{CC} / 2					
V _X	V _{OL} + 0.3 V	V _{OL} + 0.3 V	V _{OL} + 0.15 V					



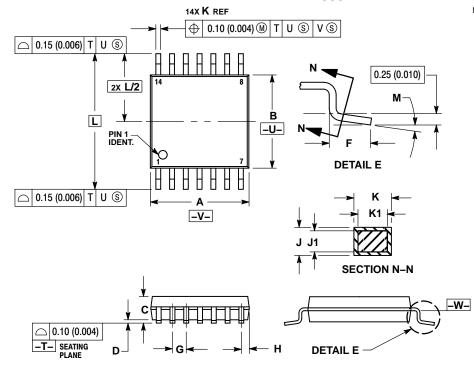
 C_L includes jig and probe capacitance R_T = Z_{OUT} of pulse generator (typically 50 Q) R_1 = R_L

Table 4. TEST CIRCUIT

Supply Voltage	lnį	Input		ad	V _{EXT}		
V _{CC} (V)	VI	t _r , t _f	CL	R_{L}	t _{PLH} , t _{PHL}	t _{PLZ} , t _{PZL}	t _{PHZ} , t _{PZH}
1.2	V _{CC}	≤ 2 ns	30 pF	1 kQ	Open	2 x V _{CC}	GND
1.65 – 1.95	V _{CC}	≤ 2 ns	30 pF	1 kQ	Open	2 x V _{CC}	GND
2.3 – 2.7	V _{CC}	≤ 2 ns	30 pF	500 Q	Open	2 x V _{CC}	GND
2.7	2.7 V	≤ 2.5 ns	50 pF	500 Q	Open	2 x V _{CC}	GND
3.0 – 3.6	2.7 V	≤ 2.5 ns	50 pF	500 Q	Open	2 x V _{CC}	GND
4.5 to 5.5	V _{CC}	≤ 2.5 ns	50 pF	500 Q	Open	2 x V _{CC}	GND

PACKAGE DIMENSIONS

TSSOP-14 **DT SUFFIX** CASE 948G **ISSUE B**

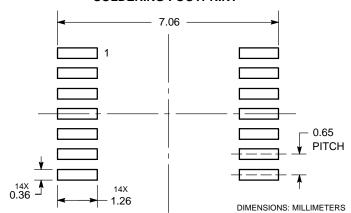


- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
 4. DIMENSION B DOES NOT INCLUDE
 - A. DIMENSION B DOES NOT INCLUDE
 INTERLEAD FLASH OR PROTRUSION.
 INTERLEAD FLASH OR PROTRUSION SHALL
 NOT EXCEED 0.25 (0.010) PER SIDE.
 - 5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
 6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
 7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE –W-.

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.10	0.193	0.200
В	4.30	4.50	0.169	0.177
С	-	1.20		0.047
D	0.05	0.15	0.002	0.006
F	0.50	0.75	0.020	0.030
G	0.65 BSC		0.026 BSC	
Н	0.50	0.60	0.020	0.024
J	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
K	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
L	6.40 BSC		0.252 BSC	
М	0 °	8°	0°	8 °

SOLDERING FOOTPRINT*

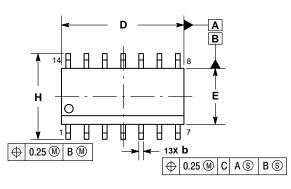


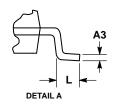
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

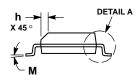
PACKAGE DIMENSIONS

SOIC-14 NB

CASE 751A-03 ISSUE K



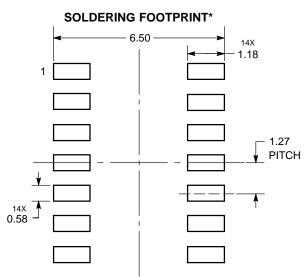




NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- 2. ODMINICION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF AT MAXIMUM MATERIAL CONDITION.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD PROTRUSIONS.
- 5. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	1.35	1.75	0.054	0.068
A1	0.10	0.25	0.004	0.010
A3	0.19	0.25	0.008	0.010
b	0.35	0.49	0.014	0.019
D	8.55	8.75	0.337	0.344
Е	3.80	4.00	0.150	0.157
е	1.27 BSC		0.050 BSC	
Н	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.019
L	0.40	1.25	0.016	0.049
М	0 °	7°	0°	7°



C SEATING PLANE

DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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74AUP1G34FW5-7 74AUP1G07FW5-7 74LVC2G126RA3-7 NLX2G17CMUTCG 74LVCE1G125FZ4-7 Le87501NQC 74AUP1G126FW5-7 TC74HC4050AP(F) 74LVCE1G07FZ4-7 NLX3G16DMUTCG NLX2G06AMUTCG NLVVHC1G50DFT2G NLU2G17AMUTCG
LE87100NQC LE87290YQC LE87290YQCT LE87511NQC LE87511NQCT LE87557NQC LE87557NQCT LE87614MQC
LE87614MQCT 74AUP1G125FW5-7 NLU2G16CMUTCG MC74LCX244MN2TWG NLV74VHC125DTR2G NL17SG126DFT2G